

ICS:

SLOVENSKI STANDARD oSIST prEN IEC 61800-3:2022

01-april-2022

Električni pogonski sistemi z nastavljivo hitrostjo - 3. del: Zahteve za elektromagnetno združljivost in posebne preskusne metode in obdelovalnih strojev

Adjustable speed electrical power drive systems - Part 3: EMC requirements and specific test methods for PDS and machine tools

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a7af-4f0f-86f0-5fa8e11b16f5/osist-pren-iec-61800-3-

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29.200	Usmerniki. Pretvorniki. Stabilizirano električno napajanje	Rectifiers. Convertors. Stabilized power supply
33.100.01	Elektromagnetna združljivost na splošno	Electromagnetic compatibility in general

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22G/450/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:

IEC 61800-3 ED4

DATE OF CIRCULATION:

2022-02-11

CLOSING DATE FOR VOTING:

11

2022-05-06

SUPERSEDES DOCUMENTS:

22G/436/CD, 22G/441A/CC

IEC SC 22G : ADJUSTABLE SPEED ELECTRIC POWER DRIVE SYSTEMS (PDS)			
SECRETARIAT:	SECRETARY:		
United States of America	Mr Christopher Johnson		
OF INTEREST TO THE FOLLOWING COMMITTEES:	PROPOSED HORIZONTAL STANDARD:		
TC 77,SC 77B, ISO/TC 39			
	Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.		
FUNCTIONS CONCERNED: 11Ch SIA	NDARD		
	QUALITY ASSURANCE SAFETY		
SUBMITTED FOR CENELEC PARALLEL VOTING	NOT SUBMITTED FOR CENELEC PARALLEL VOTING		
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The attention of IEC National Committees, members of C 61800-3:2022 CENELEC, is drawn to the fact that this Committee Draft for C 61800-3:2022 Vote (CDV) is submitted for parallel voting dards.iteh.ai/catalog/standards/sist/524acf1f-			
a7af-4f0f-86f0-5fa8e11b16 The CENELEC members are invited to vote through the CENELEC online voting system.	f5/osist-pren-iec-61800-3- 22		

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TITLE:

Adjustable speed electrical power drive systems - Part 3: EMC requirements and specific test methods for PDS and machine tools

PROPOSED STABILITY DATE: 2026

NOTE FROM TC/SC OFFICERS:

The text "with embedded PDS" has been removed from the project title (see 22G/441A/CC, JP1 on page 16).

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223	INTERNATIONAL ELECTROTECHNICAL COMMISSION
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264 265 266	International Standard IEC 61800-3 has been prepared by subcommittee 22G: Adjustable speed electric drive systems (PDS), of IEC technical committee 22: Power electronic systems and equipment.
267 268	This fourth edition cancels and replaces the third edition published in 2017. This edition constitutes a technical revision.
269 270	This edition includes the following significant technical changes with respect to the previous edition:
271	a) extension of the scope to machine tools with one or more embedded PDS;
272	b) extension of the frequency range for radiated immunity tests to 6 GHz;
273	c) general updates in the normative part and the informative annexes.
274	The text of this standard is based on the following documents:

FDIS	Report on voting
22G/XXX/FDIS	22G/XXX/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has the status of a product EMC standard in accordance with IEC guide 107 and has been drafted in accordance with the ISO/IEC Directives, Part 2.

- A list of all parts in the IEC 61800 series, published under the general title *Adjustable speed electrical power drive systems (PDS)*, can be found on the IEC website.
- The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific document. At this date, the document will be
- reconfirmed,
- e withdrawn,
- replaced by a revised edition, or
- e amended.

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ADJUSTABLE SPEED ELECTRICAL POWER
 DRIVE SYSTEMS –
 Part 3: EMC requirements and specific test methods for PDS and machine tools

294 **1 Scope**

308

This part of IEC 61800 specifies electromagnetic compatibility (EMC) requirements for adjustable speed power drive systems (PDSs). A PDS is an AC or DC motor drive including an electronic converter. It also specifies EMC requirements for machine tools (MTs). Requirements are stated for AC and DC PDSs and MTs with input and/or output voltages (line-to-line voltage), up to 35 kV AC RMS. This document applies to equipment of all power ratings.

As a product EMC standard, this document can be used for the assessment of PDS and MT. It can also be used for the assessment of complete drive modules (CDM) or basic drive modules (BDM).

303 NOTE 1 BDMs and CDMs are parts of the PDS which are often marketed separately.

Traction applications and electric vehicles are excluded. Equipment which is defined as Group 2 in CISPR 11 is excluded.

- 306 NOTE 2 Examples of Group 2 equipmentare: SIANDARD 307 - welding equipment (arc welding, resistance welding, etc)
 - electro-discharge machining equipment (EDM).

This standard does not give requirements for the electrical machine which converts power between the electrical and mechanical forms within the PDS. Requirements for rotating electrical machines are covered by the IEC 60034 series. In this standard, the term "motor" is used to describe the electrical machine, whether rotary or linear, and regardless of the direction

313 of power flow.

oSIST prEN IEC 61800-3:2022 https://standards.iteh.ai/catalog/standards/sist/524acf1f-

- This document is applicable to BDMs, CDMs, PDSs and MTs with or without radio function.
- However, this document does not specify any radio transmission and reception requirements.
- NOTE 3 It is planned that the future Edition 7 of CISPR 11 will contain a procedure how to address radio transmission
 and reception requirements, which is also applicable to products in the scope of this document.
- This document defines the minimum emission and immunity requirements in the frequency range from 0 Hz to 400 GHz. Tests are not required in frequency ranges where no requirements are specified.
- BDMs, CDMs, PDSs and MTs covered by this document are those installed in residential, commercial and industrial locations. Requirements are given according to the environment classification.
- BDMs, CDMs and PDSs are often included in a larger system. The system aspects are not covered by this document, but guidance is provided in the informative annexes.

This document is intended as a complete EMC product standard for the EMC conformity assessment of products. As an EMC product standard for BDMs, CDMs, PDSs and MTs, according to IEC Guide 107 this document takes precedence over all aspects of the generic standards.

NOTE 4 If a PDS or MT is included as part of equipment covered by a separate EMC product standard, the separate
 EMC standard applies to the complete equipment.

NOTE 5 The requirements have been selected to ensure EMC for PDSs and MTs at residential, commercial and
 industrial locations. Changes in the EMC behaviour of a PDS or an MT as a result of fault conditions are not
 considered.

NOTE 6 This document does not specify any safety requirements for the equipment such as protection against electric
 shocks, insulation co-ordination and related dielectric tests, unsafe operation, or unsafe consequences of a failure.
 It also does not cover safety and functional safety implications of electromagnetic phenomena.

338 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

- IEC 60146-1-1:2009, Semiconductor convertors General requirements and line commutated
 convertors Part 1-1: Specifications of basic requirements
- IEC 61000-2-2:2002, Electromagnetic compatibility (EMC) Part 2-2: Environment –
 Compatibility levels for low-frequency conducted disturbances and signalling in public low voltage power supply systems
- 348 IEC 61000-2-2:2002/AMD1:2017/AMD2:2018

IEC 61000-2-4:2002/COR1:2014

351

- IEC 61000-2-4:2002, Electromagnetic compatibility (EMC) Part 2-4: Environment Compatibility levels in industrial plants for low-frequency conducted disturbances
- 352 IEC 61000-3-2:2018/AMD1:2020, Electromagnetic compatibility (EMC) Part 3-2: Limits –
- Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)
- IEC 61000-3-3:2013, Electromagnetic compatibility (EMC) Part 3-3: Limits Limitation of
 voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for
 equipment with rated current ≤ 16 A per phase and not subject to conditional connection
 IEC 61000-3-3:2013/AMD1:2017

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- IEC 61000-3-11:2017, Electromagnetic compatibility (EMC) Part 3-11: Limits Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems – Equipment with rated current \leq 75 A and subject to conditional connection
- 161 IEC 61000-3-12: 2011, Electromagnetic compatibility (EMC) Part 3-12: Limits Limits for 162 harmonic currents produced by equipment connected to public low-voltage systems with input 163 current > 16 A and \leq 75 A per phase
- 364 IEC 61000-3-12: 2011/ISH:2012
- IEC 61000-4-2:2008, Electromagnetic compatibility (EMC) Part 4-2: Testing and
 measurement techniques Electrostatic discharge immunity test
- IEC 61000-4-3:2006/ISH1:2008, Electromagnetic compatibility (EMC) Part 4-3: Testing and
 measurement techniques Radiated, radio-frequency, electromagnetic field immunity test
 IEC 61000-4-3:2006/AMD1:2007/AMD2:2010
- IEC 61000-4-4:2012, Electromagnetic compatibility (EMC) Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test
- IEC 61000-4-5:2014, Electromagnetic compatibility (EMC) Part 4-5: Testing and measurement techniques Surge immunity test
- 374 IEC 61000-4-5:2014/AMD1:2017

IEC 61000-4-6:2013/COR1:2020, Electromagnetic compatibility (EMC) – Part 4-6: Testing and
 measurement techniques – Immunity to conducted disturbances, induced by radio-frequency
 fields

IEC 61000-4-8:2009, Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test

IEC 61000-4-11:2020/COR1:2020, Electromagnetic compatibility (EMC) – Part 4-11: Testing
 and measurement techniques – Voltage dips, short interruptions and voltage variations
 immunity tests for equipment with input current up to 16 A per phase

IEC 61000-4-13:2002, Electromagnetic compatibility (EMC) – Part 4-13: Testing and
 measurement techniques – Harmonics and interharmonics including mains signalling at a.c.
 power port, low frequency immunity tests
 IEC 61000-4-13:2002/AMD1:2009/AMD2:2015

IEC 61000-4-28:1999, Electromagnetic compatibility (EMC) - Part 4-28: Testing and
 measurement techniques - Variation of power frequency, immunity test for equipment with input
 current not exceeding 16 A per phase

390 IEC 61000-4-28:1999+AMD1:2001+AMD2:2009

IEC 61000-4-34:2005, Electromagnetic compatibility (EMC) – Part 4-34: Testing and
 measurement techniques – Voltage dips, short interruptions and voltage variations immunity
 tests for equipment with input current more than 16 A per phase

394 IEC 61000-4-34:2005/AMD1:2009

PREVIEW

- IEC 61000-6-1:2016, Electromagnetic compatibility (EMC) Part 6-1: Generic standards Immunity standard for residential, commercial and light-industrial environments
- IEC 61000-6-2:2016, Electromagnetic compatibility (EMC) Part 6-2: Generic standards Immunity standard for industrial environments C 61800-3:2022

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IEC 61000-6-8:2020, Electromagnetic compatibility (EMC) - Part 6-8: Generic standards Emission standard for professional equipment in commercial and light-industrial locations

- 401 IEC 61400-21-1:2019, Wind energy generation systems Part 21-1: Measurement and 402 assessment of electrical characteristics - Wind turbines
- 403 CISPR 11:2015, Industrial, scientific and medical equipment Radio-frequency disturbance 404 characteristics – Limits and methods of measurement 405 CISPR 11:2015 (AND1:2016 (AND2:2010)
- 405 CISPR 11:2015/AMD1:2016/AMD2:2019

CISPR 16-1-2:2014, Specification for radio disturbance and immunity measuring apparatus and
 methods – Part 1-2: Radio disturbance and immunity measuring apparatus – Coupling devices
 for conducted disturbance measurements
 CISPR 16.1.2:2014/AMD4:2017

409 CISPR 16-1-2:2014/AMD1:2017

CISPR 16-1-4:2019+AMD1:2020 CSV, Specification for radio disturbance and immunity
 measuring apparatus and methods – Part 1-4: Radio disturbance and immunity measuring
 apparatus – Antennas and test sites for radiated disturbance measurements

413 CISPR 16-2-3:2019, Specification for radio disturbance and immunity measuring apparatus and 414 methods – Part 2-3: Methods of measurement of disturbances and immunity – Radiated 415 disturbance measurements

CISPR 32:2015+AMD1:2019 CSV, Electromagnetic compatibility of multimedia equipment –
 Emission requirements

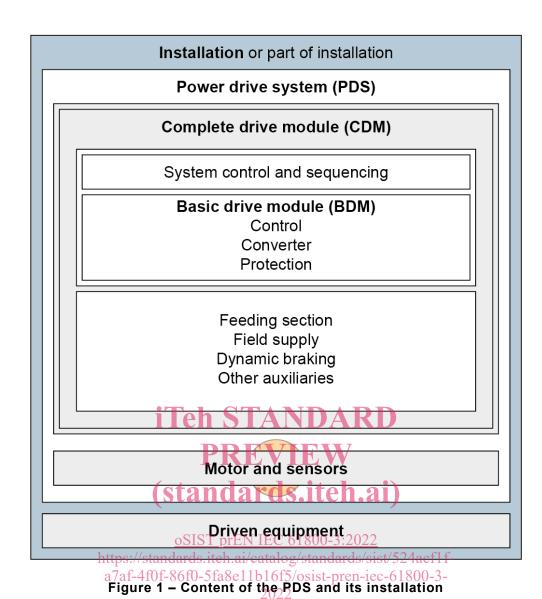
Terms and definitions 418 3

- For the purposes of this document, the following terms and definitions apply. 419
- ISO and IEC maintain terminological databases for use in standardization at the following 420 addresses: 421
- IEC Electropedia: available at http://www.electropedia.org/ 422 ٠
- ISO Online browsing platform: available at http://www.iso.org/obp 423 •

Content of the Power Drive System (PDS) and its installation 3.1 424

425 3.1.1

- basic drive module 426
- BDM 427
- electronic power converter and related control, connected between an electric supply and a 428 motor 429
- Note 1 to entry: The BDM is capable of transmitting power from the electric supply to the motor and can be capable 430 431 of transmitting power from the motor to the electric supply.
- Note 2 to entry: The BDM controls some or all of the following aspects of power transmitted to the motor and motor 432 output: current, frequency, voltage, speed, torque, force. 433
- Note 3 to entry: This note applies to the French anguage only DARD 434
- 435 3.1.2
- PREVIEW 436 complete drive module
- CDM 437
- drive module consisting of, but not limited to, the BDM and extensions such as protection 438 devices, transformers and auxiliaries, but excluding the motor and the sensors which are 439
- mechanically coupled to the motor shaft 440
- 800-3:2022 Note 1 to entry: This note applies to the French language only. https://standards.iteh.ai/catalog/standards/sist/524acf1f-441
- 3.1.3 a7af-4f0f-86f0-5fa8e11b16f5/osist-pren-iec-61800-3-442
- power drive system 443 2022
- 444 PDS
- system consisting of one or more complete drive module(s) (CDM) and a motor or motors and 445 any sensors which are mechanically coupled to the motor shaft but not including the driven 446 equipment 447
- 448 Note 1 to entry: Figure 1 illustrates the major items in the PDS. It also shows the relationship between the PDS and 449 the installation.
- 450 Note 2 to entry: This note applies to the French language only.



451 452

- 453 **3.1.4**
- 454 installation
- equipment (one or more) which include at least both the PDS and the driven equipment

456 **3.2** Content of the machine tool (MT) and its installation

- 457 **3.2.1**
- 458 machine tool

459 **MT**

- mechanical device which is fixed (i.e. not mobile) and powered (typically by electricity and
 compressed air), used to process workpieces by selective removal/addition of material and/or
 by mechanical deformation
- 463 Note 1 to entry: Machine tool operation can be mechanical, controlled by humans or by computers. Machine tools 464 can have a number of peripherals used for machine tool cooling/heating, process conditioning, workpiece and tool 465 handling (workpiece feeding excluded), recyclables and waste handling and other tasks connected to their main 466 activities.
- 467 Note 2 to entry: The machine tool is normally equipped with a power supply, an electrical and electronic assembly
 468 for power and control and one or more power drive systems for the movement of mobile elements or workpieces.
- 469 Note 3 to entry: Figure 2 illustrates the major parts of the machine tool. It also shows the position of the machine
 470 tool in the installation.
- [ISO 14955-1:2017 modified "typically used" has been replaced by "used", "may" has been replaced by "can" in Note 1 to entry, and Note 3 to entry has been added.]